

1.5V Drive Pch+Pch MOSFET

TT8J21

●Structure

Silicon P-channel MOSFET

●Features

- 1) Low On-resistance.
- 2) High Power Package.
- 3) Low voltage drive. (1.5 V)

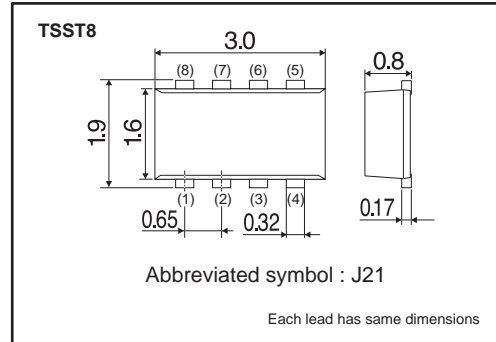
●Applications

Switching

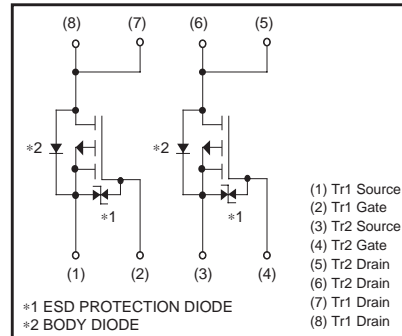
●Packaging specifications

Type	Package	Taping
	Code	TR
	Basic ordering unit (pieces)	3000
TT8J21		○

●Dimensions (Unit : mm)



●Inner circuit



●Absolute maximum ratings (Ta=25°C)

<It is the same ratings for the Tr1 and Tr2.>

Parameter	Symbol	Limits	Unit
Drain-source voltage	V_{DSS}	-20	V
Gate-source voltage	V_{GSS}	± 10	V
Drain current	Continuous	I_D	± 2.5 A
	Pulsed	I_{DP} *1	± 10 A
Source current (Body diode)	Continuous	I_S	-0.8 A
	Pulsed	I_{SP} *1	-10 A
Total power dissipation	P_D *2	1.25	W / TOTAL
		1.0	W / ELEMENT
Channel temperature	T_{ch}	150	°C
Range of Storage temperature	T_{stg}	-55 to +150	°C

*1 $P_w \leq 10\mu s$, Duty cycle $\leq 1\%$

*2 Mounted on a ceramic board

●Thermal resistance

Parameter	Symbol	Limits	Unit
Channel to ambient	$R_{th(ch-a)}$ *	100	°C / W / TOTAL
		125	°C / W / ELEMENT

* Mounted on a ceramic board

●Electrical characteristics (Ta=25°C)

<It is the same characteristics for the Tr1 and Tr2.>

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Gate-source leakage	I _{GSS}	–	–	±10	μA	V _{GS} =±10V, V _{DS} =0V
Drain-source breakdown voltage	V _{(BR) DSS}	–20	–	–	V	I _D = –1mA, V _{GS} =0V
Zero gate voltage drain current	I _{DSS}	–	–	–1	μA	V _{DS} = –20V, V _{GS} =0V
Gate threshold voltage	V _{GS(th)}	–0.3	–	–1.0	V	V _{DS} = –10V, I _D = –1mA
Static drain-source on-state resistance	R _{DS(on)} *	–	49	68	mΩ	I _D = –2.5A, V _{GS} = –4.5V
		–	68	95	mΩ	I _D = –1.2A, V _{GS} = –2.5V
		–	100	150	mΩ	I _D = –1.2A, V _{GS} = –1.8V
		–	140	280	mΩ	I _D = –0.5A, V _{GS} = –1.5V
Forward transfer admittance	Y _{fs} *	2.5	–	–	S	V _{DS} = –10V, I _D = –2.5A
Input capacitance	C _{iss}	–	1270	–	pF	V _{DS} = –10V
Output capacitance	C _{oss}	–	100	–	pF	V _{GS} =0V
Reverse transfer capacitance	C _{rss}	–	90	–	pF	f=1MHz
Turn-on delay time	t _{d(on)} *	–	9	–	ns	V _{DD} ≒ –10V
Rise time	t _r *	–	30	–	ns	V _{GS} = –4.5V I _D = –1.2A
Turn-off delay time	t _{d(off)} *	–	120	–	ns	R _L ≒ 8.3Ω
Fall time	t _f *	–	85	–	ns	R _G =10Ω
Total gate charge	Q _g *	–	12	–	nC	V _{DD} ≒ –10V V _{GS} = –4.5V
Gate-source charge	Q _{gs} *	–	2.5	–	nC	I _D = –2.5A
Gate-drain charge	Q _{gd} *	–	2.0	–	nC	R _L ≒ 4Ω / R _G =10Ω

*Pulsed

●Body diode characteristics (Source-drain) (Ta=25°C)

Parameter	Symbol	Min.	Typ.	Max.	Unit	Conditions
Forward voltage	V _{SD} *	–	–	–1.2	V	I _S = –2.5A, V _{GS} =0V

* Pulsed

●Electrical characteristic curves

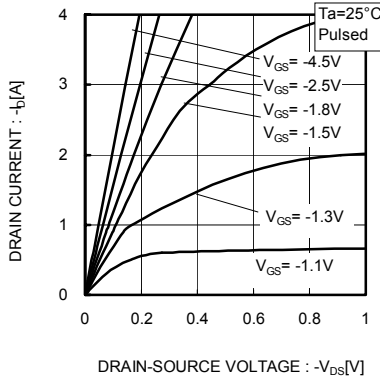


Fig.1 Typical Output Characteristics (I)

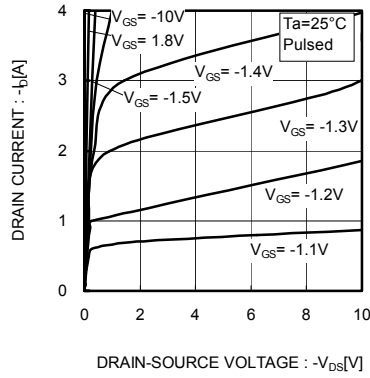


Fig.2 Typical Output Characteristics (II)

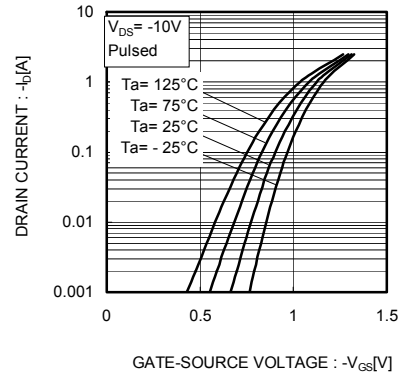


Fig.3 Typical Transfer Characteristics

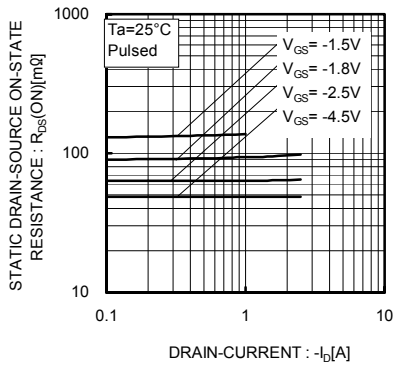


Fig.4 Static Drain-Source On-State Resistance vs. Drain

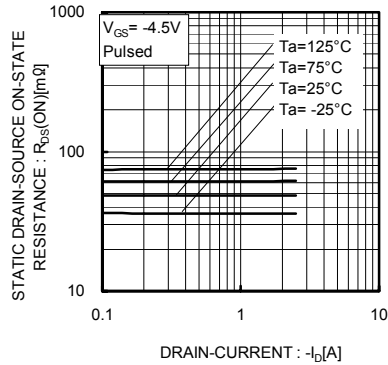


Fig.5 Static Drain-Source On-State Resistance vs. Drain

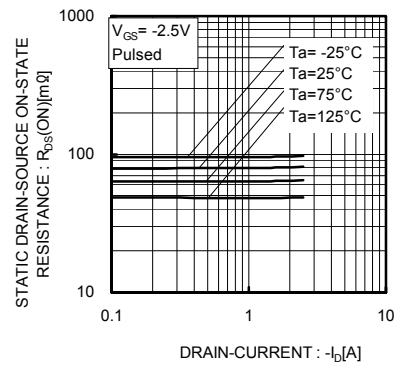


Fig.6 Static Drain-Source On-State Resistance vs. Drain Current(III)

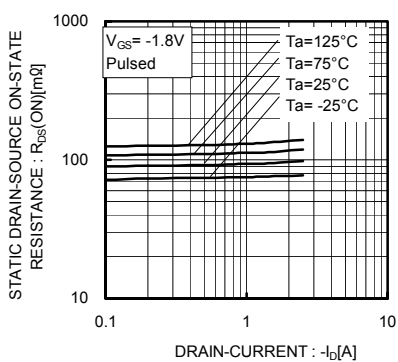


Fig.7 Static Drain-Source On-State Resistance vs. Drain Current(IV)

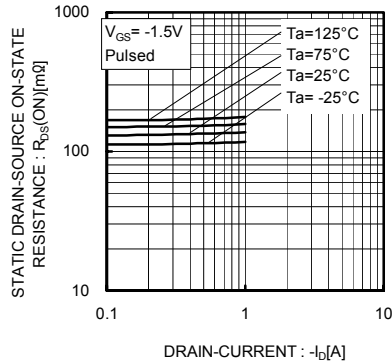


Fig.8 Static Drain-Source On-State Resistance vs. Drain Current(IV)

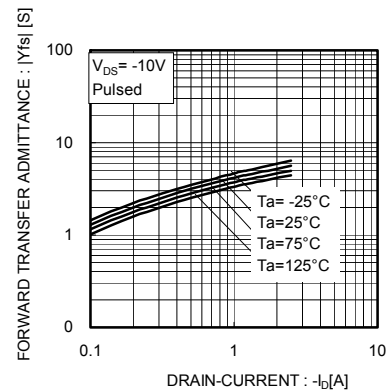
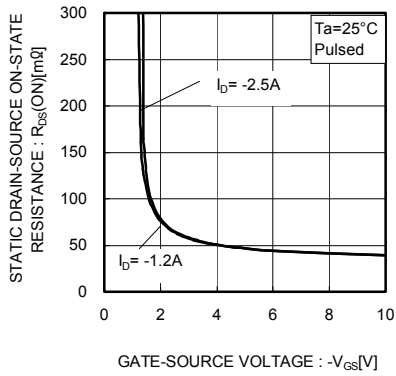
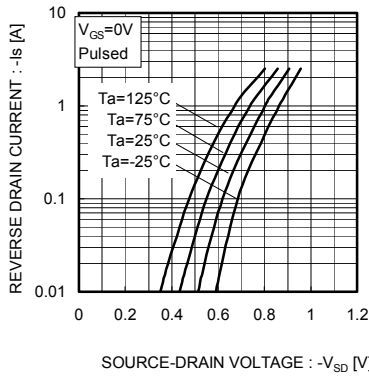


Fig.9 Forward Transfer Admittance vs. Drain Current



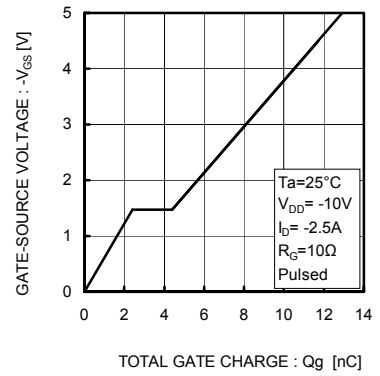
GATE-SOURCE VOLTAGE : $-V_{GS}[V]$

Fig.10 Static Drain-Source On-State Resistance vs. Gate Source Voltage



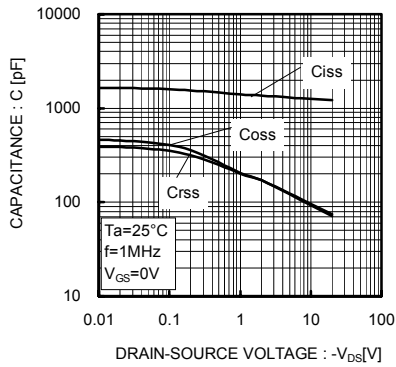
SOURCE-DRAIN VOLTAGE : $-V_{SD}[V]$

Fig.11 Reverse Drain Current vs. Source-Drain Voltage



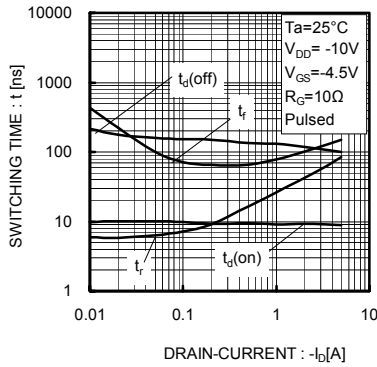
TOTAL GATE CHARGE : $Q_g[nC]$

Fig.12 Dynamic Input Characteristics



DRAIN-SOURCE VOLTAGE : $-V_{DS}[V]$

Fig.13 Typical Capacitance vs. Drain-Source



DRAIN-CURRENT : $-I_D[A]$

Fig.14 Switching Characteristics

●Measurement circuits

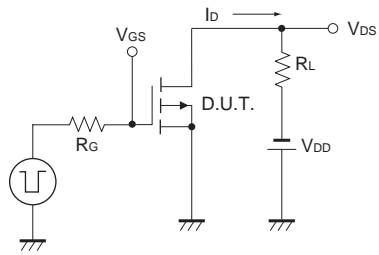


Fig.1-1 Switching Time Measurement Circuit

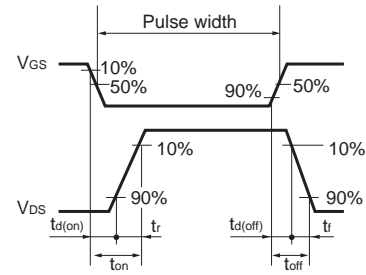


Fig.1-2 Switching Waveforms

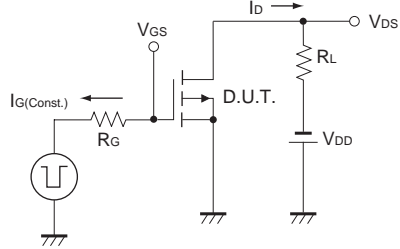


Fig.2-1 Gate Charge Measurement Circuit

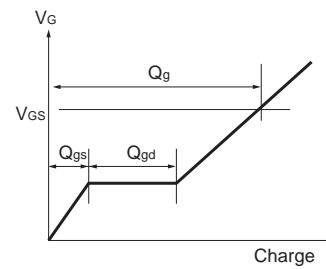


Fig.2-2 Gate Charge Waveform

●Notice

This product might cause chip aging and breakdown under the large electrified environment. Please consider to design ESD protection circuit.

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